

<b>Notice of References Cited</b>	Application/Control No. 10/566,832	Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL.	
	Examiner Kevin P. Kerns	Art Unit 1725	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,107,601	08-2000	Shimogama	219/130.01
*	B	US-6,555,786	04-2003	Sasano	219/137.71
*	C	US-6,750,428	06-2004	Okamoto et al.	219/130.5
*	D	US-7,105,771	09-2006	Inoue et al.	219/125.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 386 791 A2	09-1990	EPO	Sarugaku et al.	G05B 19/23
	O	JP 2003-285167 A	10-2003	Japan	Nishimura et al.	B23K 9/32
	P	JP 2003-285167translation	10-2003	Japan	Nishimura et al.	B23K 9/32
	Q	JP 2004-223576 A	08-2004	Japan	Inoue et al.	B23K 9/133
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.